

Subject card

Subject name and code	Metrology, PG_00047552									
Field of study	Automatic Control, Cybernetics and Robotics									
Date of commencement of studies	•		Academic year of realisation of subject			2020/2021				
Education level	first-cycle studies		Subject group			Obligatory subject group in the field of study				
Mode of study	Full-time studies		Mode of delivery			at the university				
Year of study	1		Language of instruction			Polish				
Semester of study	2		ECTS credits			1.0				
Learning profile	general academic profile		Assessment form			assessment				
Conducting unit	Department of Metrology and Optoelectronics -> Faculty of Electronics, Telecomm					munications a	and Informatics			
Name and surname	Subject supervisor		dr inż. Sylwia Babicz-Kiewlicz							
of lecturer (lecturers)	Teachers		dr inż. Sylwia Babicz-Kiewlicz							
Lesson types and methods	Lesson type	Lecture	Tutorial	Laboratory Project		:t	Seminar	SUM		
of instruction	Number of study hours	15.0	0.0	0.0	0.0		0.0	15		
	E-learning hours included: 0.0									
	Adresy na platformie	eNauczanie:								
Learning activity and number of study hours	Learning activity	Participation in didactic classes included in study plan		Participation in consultation hours		Self-study		SUM		
	Number of study hours	15		1.0		9.0		25		
Subject objectives	The aim is introduction to : the essence of measurement, units and standards, methods of measurement, analysis of measurement uncertainty, basic instruments for measurement of electrical quantities.									
Learning outcomes	Course outcome		Subject outcome			Method of verification				
	[K6_W03] Knows and understands, to an advance extent, the construction and operating principles of components and systems re to the field of study, including theories, methods and comprelationships between them selected specific issues - appropriate for the curriculu			Zna budowę oraz właściwości metrologiczne przyrządów do pomiaru podstawowych wielkości elektrycznych. Zna zasady działania przetworników analogowo/cyfrowych. Zna metody konstruowania systemów pomiarowych.			[SW1] Assessment of factual knowledge			
[K6_W02] Knows and understands, to an advanced extent, selected laws of physics and physical phenomena as well as methods and theories explaining the complex relationships between them, constituting the basic general knowledge in the field of technical sciences related to the field of study		Knows basic metrology terms. Knows the methods of measurement. Strictly defines the measurand (menzurand). Presents the results of measurements according to the recommendations of the International System of Units SI, using correct designations and prefixes to form multiple and aliquot units of measurement. Analyses systematic errors in direct and indirect measurements. Knows the causes of measurement uncertainty and how to minimise it during measurement. Evaluates the uncertainty of Type A and Type B methods of measurement.			[SW1] Assessment of factual knowledge					

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Subject contents	1. Introduction, basic metrological terms, classification of measurement methods 2. Measurement errors, types of errors: systematic, random, gross 3. Permanent-magnet moving-coil instrument and its application 4. Digital methods of low and high frequency measurements 5. Digital methods of time-interval and phase measurements 6. Dual-slope integration ADC 7. Immunity of integration ADCs from disturbances 8. Flash and subranging ADC 9. Digital multimeters: architecture, resistance to voltage converter, current to voltage converter, multiterminal inputs 10. AC voltage measurements, waveform parameters, average value, peak value and RMS measurements 11. Oscilloscope: architecture, principles of operation 12. Measurements of voltage, frequency, phase, parameters of pulse, display of device characteristics 13. Measurement uncertainty 14. Measurement methods of impedance parameters R, L, C, Z 15. Measuring systems and virtual instruments.						
Prerequisites and co-requisites	No requirements						
Assessment methods	Subject passing criteria	Passing threshold	Percentage of the final grade				
and criteria	Colloquium	50.0%	100.0%				
Recommended reading	Basic literature 1. Dusza J.: Podstawy miernictwa. OWPW, Warszawa 2002. 2. Lisowski M.: Podstawy metrologii, OWPW, Wrocław 2011. 3. Tumań S.: Technika pomiarowa, WNT, Warszawa 2007. 4. Kamieniecki A.: Współczesny oscyloskop. Budowa i pomiary, Wydawnictwo btc, Legionowo 2009. 5. Stabrowski M.: Cyfrowe przyrządy pomiarowe. Wyd. Naukowe PWN, Warszawa 2002. 6. Zięba A.: Analiza danych naukach ścisłych i technice, PWN, Warszawa 2013.						
	Supplementary literature	No requirements					
	eResources addresses						
Example issues/ example questions/ tasks being completed	1 Two voltmeters could be used to measure the voltage U = 12 V. The first was a class 0.5 laboratory voltmeter with a measuring range of 60 V, and the second was a class 1.5 blackboard voltmeter with a measuring range of 15 V. Which voltmeter allowed the voltage value to be determined with less error?2) What is the measured frequency if 3587 pulses were counted in the 10 ms gate-opening time of the frequency meter. 3. a frequency meter, normally operating with an internal reference frequency source of 1 MHz, was used with an external reference generator of 4 MHz. How should the frequency measurement results be corrected: (a) multiply by 4, (b) multiply by 2, (c) divide by 4.4. represent in the figure the voltage waveform that occurs at the output of the integrator in an A/D converter with double integration processing. Mark with "a" the time interval in which the reference voltage is integrated, with "b" the time interval in which the measured voltage is integrated, with "c" the time interval proportional to the measured voltage, with "d" the moment when the state of the comparator output changes, with "e" the moment when the counter overflows, with "f" the time interval which is to be equal to 20 ms to ensure immunity of the converter to mains frequency interference. The Y channel of the oscilloscope has a bandwidth of 40 MHz. What is the rise time of the step response of the oscilloscope. What is the rise time of the pulse you will read from the screen of this oscilloscope if you are testing a pulse whose rise time is 20 ns.6. The uncertainty of the voltage measurement is expressed in the multimeter specification as ±(1%+2 digits) and the reading is 1.200 V. Calculate the uncertainty of the voltage measurement. 7 Explain the meaning of the abbreviations read from the face plate of the multimeter: AC, DC, 2W, 4W.8. Express the voltage ratios in dB: U1/U2 = 103, 1, 10-2.9. give the rms and peak-to-peak value of the voltage in a domestic power network.10. Why is a four-wire connection between a resistor and a me						
Work placement	Not applicable						

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